

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/960,668	OFEK ET AL.	
Examiner	Art Unit	
Leslie Pascal	2633	

	SEARCHED					
Class	Subclass	Date	Examiner			
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH (INCLUDING SEAR	NOTES CH STRATEGY	)
	DATE	EXMR
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